

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/579,194	LEE ET AL.	
Examiner	Art Unit	
Krishnan C Manan	1707	

	SEARCHED				
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor search; 210/650,652,321.69,500.23, 490	11/6/2008	KM	
updated	4/6/2009	KM	